

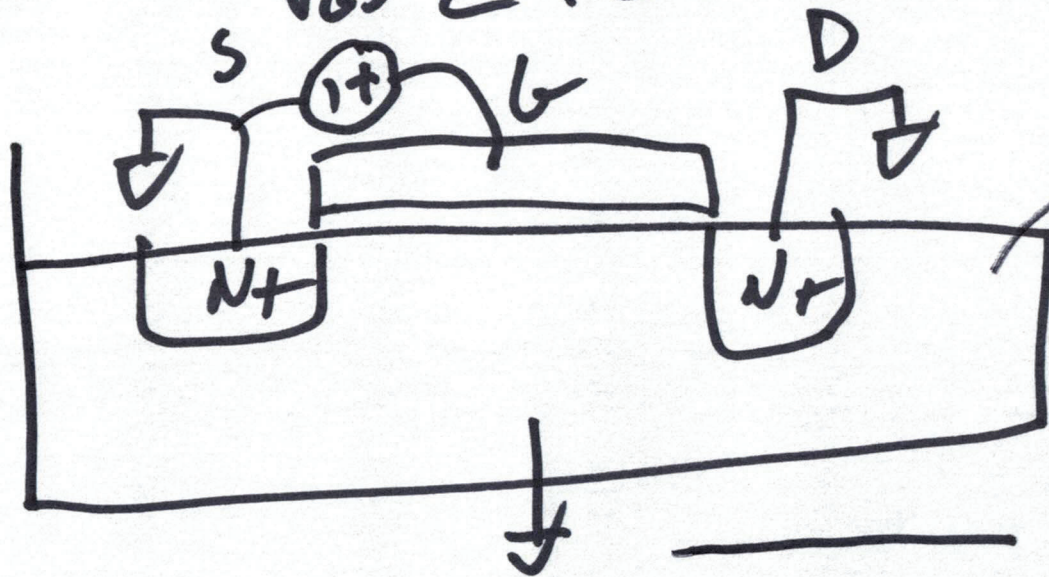
EE 421 / ECG 621

# Digital IC Design

fermi energy  
prob. of elec = 50%

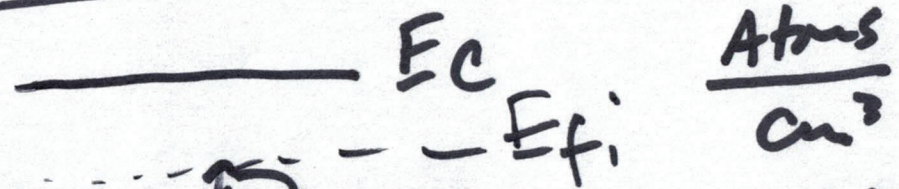
OCT. 4, 2023

## V<sub>GS</sub> Lecture II



doping of substrate, NA  
# of acceptor atoms,

$$V_{fp} = \frac{1}{q} \cdot E_{fp}$$



$$V_{fp} = \frac{-kT}{q} \ln \frac{NA}{ni}$$

intrinsic carrier concentration



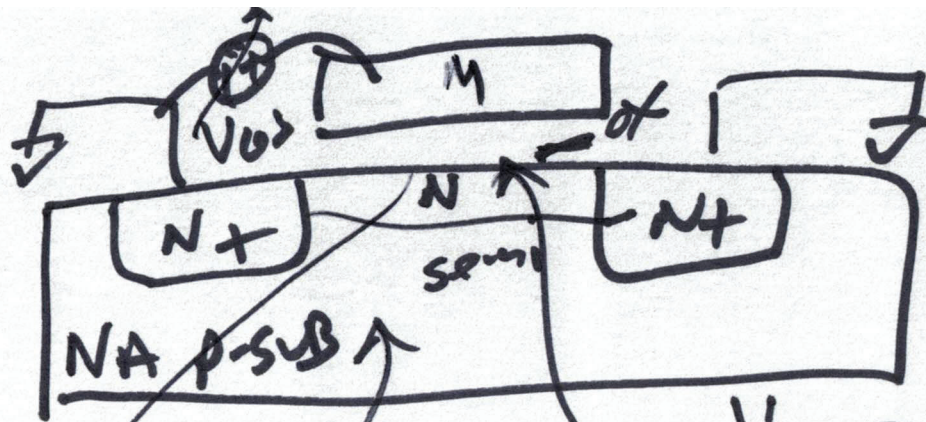
$$V_{FP} = \frac{KT}{q} \ln \frac{N_A}{n_i} = \frac{KT}{q} \ln \left( \frac{N_A}{n_i} \right)^{-1}$$

$$\ln a - \ln b = \ln \frac{a}{b} \quad -\ln a = \ln a^{-1}$$

$$V_{FP} = \frac{KT}{q} \ln \frac{n_i}{N_A}$$

$$V_{bi} = V_{FN} - V_{FP} = \frac{KT}{q} \ln \frac{N_D}{n_i} - \frac{KT}{q} \ln \frac{n_i}{N_A}$$

$$V_{bi} = \frac{KT}{q} \ln \frac{N_D N_A}{n_i^2}$$



$V_s =$  surface potential

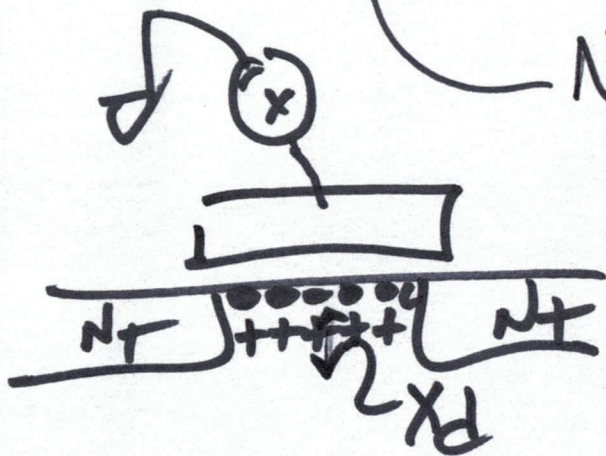
Bulk

$$V_{fp} = -\frac{kT}{q} \ln \frac{N_A}{N_i}$$

$V_s = V_{fp}$   
NO Applied voltage

NA → 0 → N+ (# of electrons)

depletion ↑  
at  $V_{thn}$  (threshold voltage)



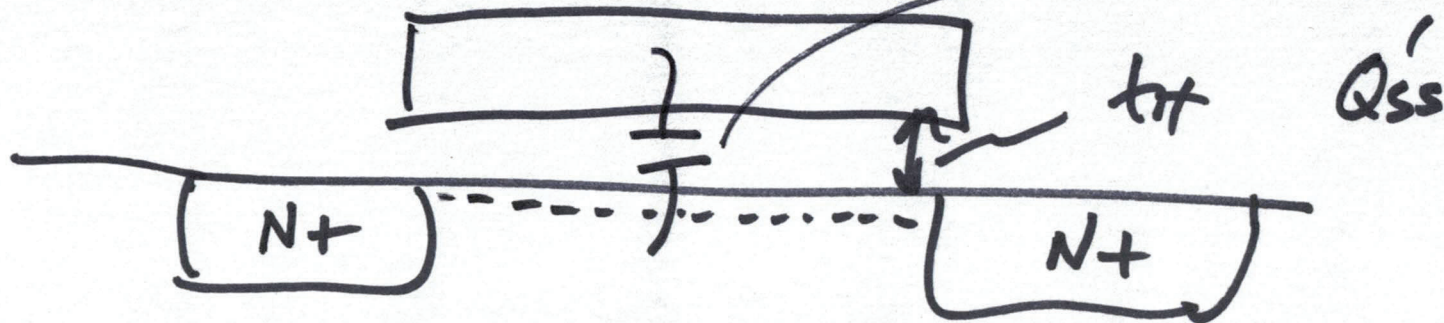
3)

$$V_G - V_{ox} + V_{ox} - V_{fp} \text{ CHIPS ACT}$$

H<sub>2</sub>O

$$V_G - V_{fp}$$

$$C'_{ox} = \frac{\epsilon_{ox}}{t_{ox}}$$

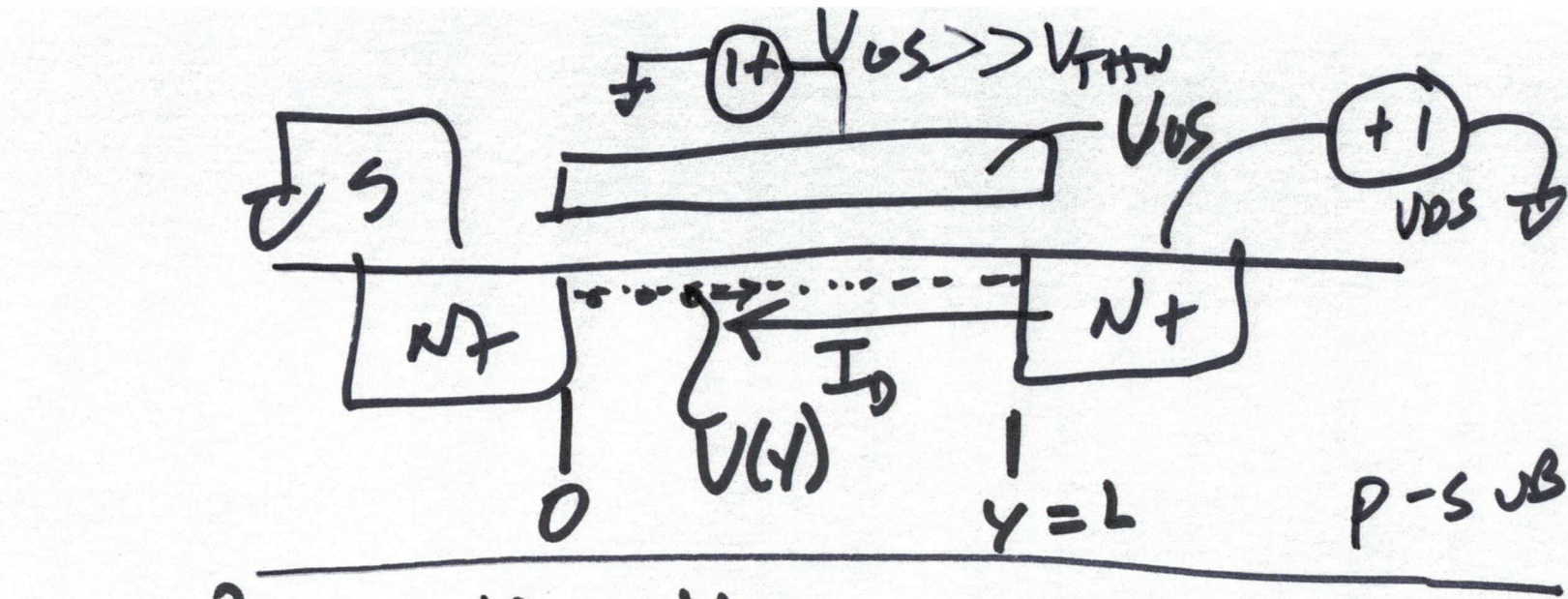


$$C_V = Q$$

p-sub

$$V_{THN} = \frac{Q_D}{C'_{ox}} - \frac{Q_{ss}}{C'_{ox}} - \frac{V_G - V_{fp}}{\text{CONTACT potentials}}$$

$$- 2V_{fp}$$



$$C'V = Q$$

$$V_{GS} = V_{TTHW}$$

$$Q'_b = C'_{ox} \cdot V_{TTHW}$$

$$Q'_{CH} = Q'_b + Q'_{CH}$$

↑ inverted total channel

available to conduct current

$$Q'_{CH} = (V_{GS} - V(y)) \cdot C'_{ox}$$